# 10 μV Offset, 0.07 μV/°C, Zero-Drift Operational Amplifier

The NCS333/2333/4333 family of zero–drift op amps feature offset voltage as low as 10  $\mu V$  over the 1.8 V to 5.5 V supply voltage range. The zero–drift architecture reduces the offset drift to as low as 0.07  $\mu V/^{\circ} C$  and enables high precision measurements over both time and temperature. This family has low power consumption over a wide dynamic range and is available in space saving packages. These features make it well suited for signal conditioning circuits in portable, industrial, automotive, medical and consumer markets.

#### **Features**

- Gain-Bandwidth Product:
  - 270 kHz (NCx2333)
  - 350 kHz (NCx333, NCx333A, NCx4333)
- Low Supply Current: 17 μA (typ at 3.3 V)
- Low Offset Voltage:
  - 10 μV max for NCS333, NCS333A
  - 30 μV max for NCV333A, NCx2333 and NCx4333
- Low Offset Drift: 0.07 μV/°C max for NCS333/A
- Wide Supply Range: 1.8 V to 5.5 V
- Wide Temperature Range: -40°C to +125°C
- Rail-to-Rail Input and Output
- Available in Single, Dual and Quad Packages
- NCV Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q100 Qualified and PPAP Capable

#### **Applications**

- Automotive
- Battery Powered/ Portable Application
- Sensor Signal Conditioning
- Low Voltage Current Sensing
- Filter Circuits
- Bridge Circuits
- Medical Instrumentation



#### ON Semiconductor®

www.onsemi.com



SOT23-5 SN SUFFIX CASE 483



SC70-5 SQ SUFFIX CASE 419A



UDFN8 MU SUFFIX CASE 517AW



MSOP-8 DM SUFFIX CASE 846A-02



SOIC-8 D SUFFIX CASE 751



SOIC-14 D SUFFIX CASE 751A

#### **DEVICE MARKING INFORMATION**

See general marking information in the device marking section on page 2 of this data sheet.

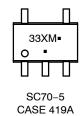
#### **ORDERING INFORMATION**

See detailed ordering and shipping information on page 3 of this data sheet.

#### **DEVICE MARKING INFORMATION**

# Single Channel Configuration NCS333, NCS333A, NCV333A





TSOP-5/SOT23-5 CASE 483

## Dual Channel Configuration NCS2333, NCV2333



UDFN8, 2x2, 0.5P CASE 517AW

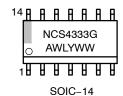


Micro8/MSOP8 CASE 846A-02



SOIC-8 CASE 751

## Quad Channel Configuration NCS4333, NCV4333



CASE 751A

X = Specific Device Code

E = NCS333 (SOT23-5)

H = NCS333 (SC70-5)

G = NCS333A (SOT23-5) K = NCS333A (SC70-5)

M = NCV333A (SOT23-5)

N = NCV333A (SC70-5)

A = Assembly Location

Y = Year W = Work Week

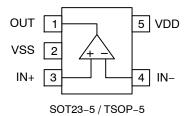
M = Date Code

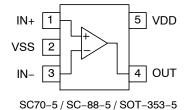
G or ■ = Pb-Free Package

(Note: Microdot may be in either location)

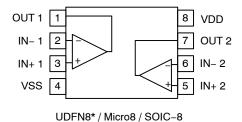
#### **PIN CONNECTIONS**

# Single Channel Configuration NCS333, NCS333A, NCV333A



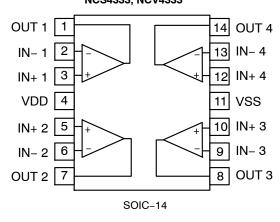


# Dual Channel Configuration NCS2333, NCV2333



\*The exposed pad of the UDFN8 package can be floated or connected to VSS.

## Quad Channel Configuration NCS4333, NCV4333



#### **ORDERING INFORMATION**

Configuration	Automotive	Device	Package	Shipping <sup>†</sup>
Single	No	NCS333SN2T1G	SOT23-5 / TSOP-5	3000 / Tape & Reel
		NCS333ASN2T1G		3000 / Tape & Reel
		NCS333SQ3T2G	SC70-5 / SC-88-5 / SOT-353-5	3000 / Tape & Reel
		NCS333ASQ3T2G		3000 / Tape & Reel
	Yes	NCV333ASQ3T2G		3000 / Tape & Reel
		NCV333ASN2T1G	SOT23-5 / TSOP-5	3000 / Tape & Reel
Dual	No	NCS2333MUTBG	UDFN8	3000 / Tape & Reel
		NCS2333DR2G	SOIC-8	3000 / Tape & Reel
		NCS2333DMR2G	MICRO-8	4000 / Tape & Reel
	Yes	NCV2333DR2G	SOIC-8	3000 / Tape & Reel
		NCV2333DMR2G	MICRO-8	4000 / Tape & Reel
Quad	No	NCS4333DR2G	SOIC-14	2500 / Tape & Reel
	Yes	NCV4333DR2G	SOIC-14	2500 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

#### **ABSOLUTE MAXIMUM RATINGS**

Over operating free-air temperature, unless otherwise stated.

Parameter	Rating	Unit	
Supply Voltage	7	V	
INPUT AND OUTPUT PINS		•	
Input Voltage (Note 1)	(VSS) - 0.3 to (VDD) + 0.3	V	
Input Current (Note 1)	±10	mA	
Output Short Circuit Current (Note 2)	Continuous		
TEMPERATURE		•	
Operating Temperature Range	-40 to +125	°C	
Storage Temperature Range	-65 to +150	°C	
Junction Temperature	+150	°C	
ESD RATINGS (Note 3)		•	
Human Body Model (HBM)	±4000	V	
Machine Model (MM)	±200	V	
Charged Device Model (CDM)	±2000	V	
OTHER RATINGS			
Latch-up Current (Note 4)	100	mA	
MSL	Level 1		

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- 1. Input terminals are diode-clamped to the power-supply rails. Input signals that can swing more than 0.3 V beyond the supply rails should be current limited to 10 mA or less
- 2. Short-circuit to ground.
- 3. This device series incorporates ESD protection and is tested by the following methods:
  - ESD Human Body Model tested per JEDEC standard JS-001 (AEC-Q100-002)
  - ESD Machine Model tested per JEDEC standard JESD22-A115 (AEC-Q100-003)
  - ESD Charged Device Model tested per JEDEC standard JESD22-C101 (AEC-Q100-011)
- 4. Latch-up Current tested per JEDEC standard: JESD78.

#### THERMAL INFORMATION (Note 5)

Parameter	Symbol	Package	Value	Unit
Thermal Resistance,	$\theta_{\sf JA}$	SOT23-5 / TSOP5	290	°C/W
Junction to Ambient		SC70-5 / SC-88-5 / SOT-353-5	425	
		Micro8 / MSOP8	298	
		SOIC-8	250	
		UDFN8	228	
		SOIC-14	216	

<sup>5.</sup> As mounted on an 80x80x1.5 mm FR4 PCB with 650 mm<sup>2</sup> and 2 oz (0.07 mm) thick copper heat spreader. Following JEDEC JESD/EIA 51.1, 51.2, 51.3 test guidelines

#### RECOMMENDED OPERATING CONDITIONS

Parameter	Symbol	Range	Unit	
Supply Voltage (V <sub>DD</sub> – V <sub>SS</sub> )		$V_S$	1.8 to 5.5	V
Specified Operating Temperature Range	NCS333	$T_A$	-40 to 105	°C
NCx333A, NCx2333	3, NCx4333		-40 to 125	
Input Common Mode Voltage Range		V <sub>ICMR</sub>	V <sub>SS</sub> -0.1 to V <sub>DD</sub> +0.1	V

Functional operation above the stresses listed in the Recommended Operating Ranges is not implied. Extended exposure to stresses beyond the Recommended Operating Ranges limits may affect device reliability.

**ELECTRICAL CHARACTERISTICS:**  $V_S = 1.8 \text{ V to } 5.5 \text{ V}$  At  $T_A = +25^{\circ}\text{C}$ ,  $R_L = 10 \text{ k}\Omega$  connected to midsupply,  $V_{CM} = V_{OUT} =$  midsupply, unless otherwise noted. **Boldface** limits apply over the specified operating temperature range, guaranteed by characterization and/or design.

Parameter	Symbol	Conditions		Min	Тур	Max	Unit
INPUT CHARACTERISTICS					•		
Offset Voltage	V <sub>OS</sub>	V <sub>S</sub> = +5 V	NCS333, NCS333A		3.5	10	μV
			NCV333A, NCx2333, NCx4333		6.0	30	
Offset Voltage Drift vs Temp	$\Delta V_{OS}/\Delta T$	NCS333,	NCS333A		0.03	0.07	μV/°C
		NCV333A	A, V <sub>S</sub> = 5 V		0.03	0.14	
		NCx2333	3, V <sub>S</sub> = 5 V		0.04	0.07	
		NCx4333	3, V <sub>S</sub> = 5 V		0.095	0.19	
Offset Voltage Drift vs Supply	$\Delta V_{OS}/\Delta V_{S}$	NCS333, NCS333A	Full temperature range		0.32	5	μV/V
		NCV333A	T <sub>A</sub> = +25°C		0.40	5	
			Full temperature range			8	
		NCx2333, NCx4333	T <sub>A</sub> = +25°C		0.32	5	
			Full temperature range			12.6	
Input Bias Current	I <sub>IB</sub>	T <sub>A</sub> = +25°C	NCS333, NCx333A		±60	±200	pА
(Note 6)			NCx2333, NCx4333		±60	±400	
		Full temperature range			±400		
Input Offset Current (Note 6)	los	T <sub>A</sub> = +25°C	NCS333, NCx333A		±50	±400	pА
			NCx2333, NCx4333		±50	±800	
Common Mode Rejection Ratio	CMRR	V <sub>S</sub> = 1.8 V			111		dB
(Note 7)		V <sub>S</sub> = 3.3 V			118		
		V <sub>S</sub> = 5.0 V	NCS333, NCS333A, NCx2333, NCx4333	106	123		
			NCV333A	103	123		
		V <sub>S</sub> =	5.5 V		127		
Input Resistance	R <sub>IN</sub>	Diffe	rential		180		GΩ
		Commo	on Mode		90		
Input Capacitance	C <sub>IN</sub>	NCS333	Differential		2.3		pF
			Common Mode		4.6		
		NCx2333, NCx4333,	Differential		4.1		
		NCx333A	Common Mode		7.9		
OUTPUT CHARACTERISTICS							•
Open Loop Voltage Gain (Note 6)	A <sub>VOL</sub>	$V_{SS}$ + 100 mV < $V_{O}$ < $V_{DD}$ – 100 mV		106	145		dB
Open Loop Output Impedance	Z <sub>out-OL</sub>	f = UGBW, I <sub>O</sub> = 0 mA			300		Ω
Output Voltage High,	V <sub>OH</sub>	T <sub>A</sub> =	+25°C		10	50	mV
Referenced to V <sub>DD</sub>		Full temper	rature range			70	
Output Voltage Low,	V <sub>OL</sub>	T <sub>A</sub> =	+25°C		10	50	mV
Referenced to V <sub>SS</sub>		Full tempe	rature range			70	

<sup>6.</sup> Guaranteed by characterization and/or design 7. Specified over the full common mode range:  $V_{SS}$  – 0.1 <  $V_{CM}$  <  $V_{DD}$  + 0.1

#### **ELECTRICAL CHARACTERISTICS:** $V_S = 1.8 \text{ V to } 5.5 \text{ V}$

At  $T_A = +25^{\circ}C$ ,  $R_L = 10 \text{ k}\Omega$  connected to midsupply,  $V_{CM} = V_{OUT} =$  midsupply, unless otherwise noted. **Boldface** limits apply over the specified operating temperature range, guaranteed by characterization and/or design.

Parameter	Symbol	Cond	itions	Min	Тур	Max	Unit
OUTPUT CHARACTERISTICS	•	•					•
Output Current Capability	Io	Sinking Current	NCS333		25		mA
			NCx333A, NCx2333, NCx4333		11		
		Sourcing	g Current		5.0		1
Capacitive Load Drive	CL			S	ee Figure	13	
NOISE PERFORMANCE	•						
Voltage Noise Density	e <sub>N</sub>	f <sub>IN</sub> =	1 kHz		62		nV / √Hz
Voltage Noise	e <sub>P-P</sub>	f <sub>IN</sub> = 0.1 H	Iz to 10 Hz		1.1		$\mu V_{PP}$
		f <sub>IN</sub> = 0.01	Hz to 1 Hz		0.5		1
Current Noise Density	i <sub>N</sub>	f <sub>IN</sub> =	10 Hz		350		fA / √Hz
Channel Separation		NCx2333	NCx4333		135		dB
DYNAMIC PERFORMANCE		•					
Gain Bandwidth Product	GBWP	C <sub>L</sub> = 100 pF	NCS333, NCx333A, NCx4333		350		kHz
			NCx2333		270		1
Gain Margin	A <sub>M</sub>	C <sub>L</sub> = -	100 pF		18		dB
Phase Margin	$\phi$ M	C <sub>L</sub> = -	100 pF		55		٥
Slew Rate	SR	G =	: +1		0.15		V/μs
POWER SUPPLY	•	•				•	•
Power Supply Rejection Ratio	PSRR	NCS333, NCS333A	Full temperature range	106	130		dB
		NCx2333, NCx4333,	T <sub>A</sub> = +25°C	106	130		1
		NCV333A	Full temperature range	98			1
Turn-on Time	t <sub>ON</sub>	V <sub>S</sub> =	= 5 V		100		μs
Quiescent Current	IQ	NCS333, NCS333A,	$1.8 \text{ V} \le \text{V}_{\text{S}} \le 3.3 \text{ V}$		17	25	μА
(Note 8)		NCx2333, NCx4333				27	1
			3.3 V < V <sub>S</sub> ≤ 5.5 V		21	33	1
						35	1
		NCV333A	$1.8 \text{ V} \le \text{V}_{\text{S}} \le 3.3 \text{ V}$		20	30	1
						35	1
			3.3 V < V <sub>S</sub> ≤ 5.5 V		28	40	1
						45	1

<sup>8.</sup> No load, per channel

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

#### **TYPICAL CHARACTERISTICS**

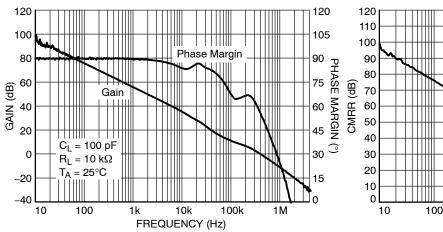


Figure 1. Open Loop Gain and Phase Margin vs. Frequency

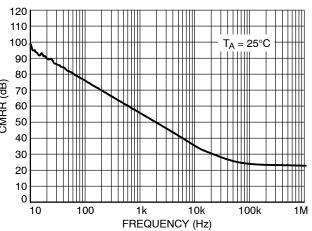


Figure 2. CMRR vs. Frequency

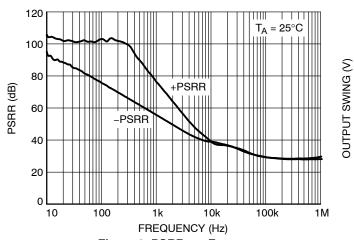


Figure 3. PSRR vs. Frequency

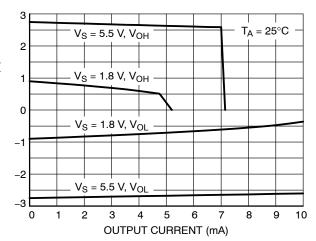
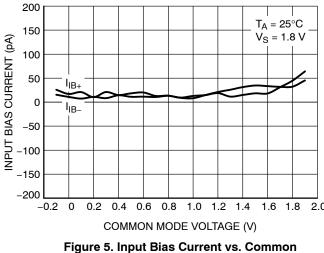


Figure 4. Output Voltage Swing vs. Output Current

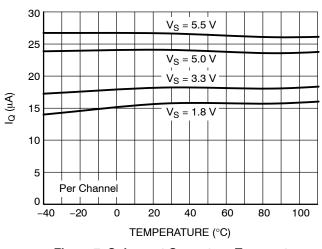
#### **TYPICAL CHARACTERISTICS**



200 150 (pA) 100 INPUT BIAS CURRENT  $I_{IB+}$ 50  $I_{IB}$ 0 -50  $T_A = 25^{\circ}C$ -100  $V_S = 5 V$ -150 -200 20 -20 0 40 60 80 100 -40 TEMPERATURE (°C)

Figure 5. Input Bias Current vs. Common Mode Voltage

Figure 6. Input Bias Current vs. Temperature



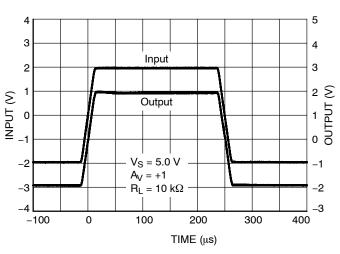
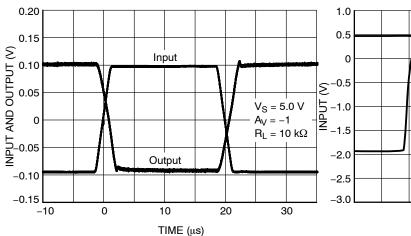


Figure 7. Quiescent Current vs. Temperature

Figure 8. Large Signal Step Response





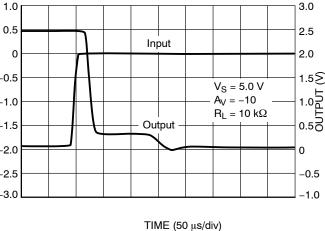


Figure 10. Positive Overvoltage Recovery

#### TYPICAL CHARACTERISTICS

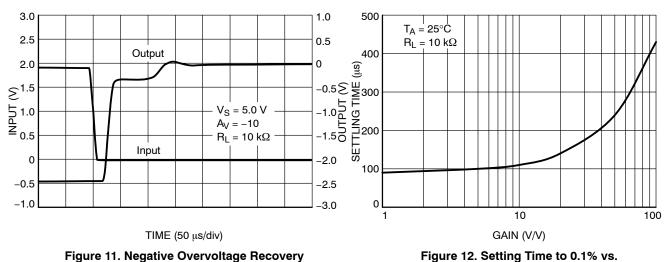


Figure 11. Negative Overvoltage Recovery

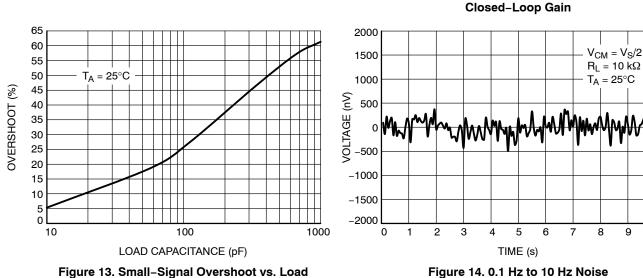


Figure 13. Small-Signal Overshoot vs. Load Capacitance

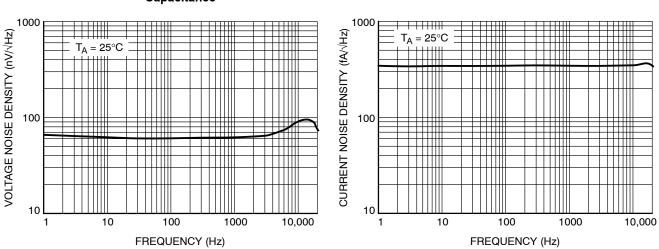


Figure 15. Voltage Noise Density vs. Frequency

Figure 16. Current Noise Density vs. Frequency

10

#### **APPLICATIONS INFORMATION**

#### **OVERVIEW**

The NCS333, NCS333A, NCS2333, and NCS4333 precision op amps provide low offset voltage and zero drift over temperature. The input common mode voltage range extends 100 mV beyond the supply rails to allow for sensing near ground or VDD. These features make the NCS333 series well–suited for applications where precision is required, such as current sensing and interfacing with sensors.

NCS333 series of precision op amps uses a chopper-stabilized architecture, which provides the advantage of minimizing offset voltage drift over temperature and time. The simplified block diagram is shown in Figure 17. Unlike the classical chopper architecture, the chopper stabilized architecture has two signal paths.

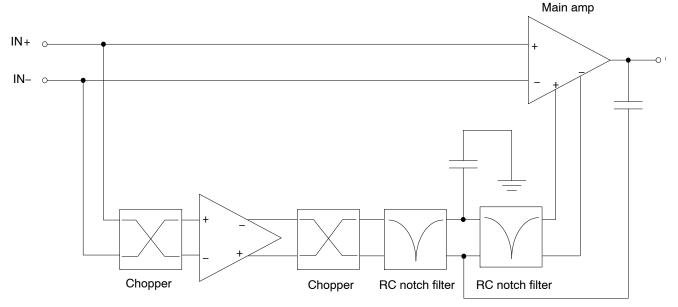


Figure 17. Simplified NCS333 Block Diagram

In Figure 17, the lower signal path is where the chopper samples the input offset voltage, which is then used to correct the offset at the output. The offset correction occurs at a frequency of 125 kHz. The chopper-stabilized architecture is optimized for best performance at frequencies up to the related Nyquist frequency (1/2 of the offset correction frequency). As the signal frequency exceeds the Nyquist frequency, 62.5 kHz, aliasing may occur at the output. This is an inherent limitation of all chopper chopper-stabilized architectures. Nevertheless, the NCS333 op amps have minimal aliasing up to 125 kHz and low aliasing up to 190 kHz when compared to competitor parts from other manufacturers. ON Semiconductor's patented approach utilizes two

cascaded, symmetrical, RC notch filters tuned to the chopper frequency and its fifth harmonic to reduce aliasing effects.

The chopper–stabilized architecture also benefits from the feed–forward path, which is shown as the upper signal path of the block diagram in Figure 17. This is the high speed signal path that extends the gain bandwidth up to 350 kHz. Not only does this help retain high frequency components of the input signal, but it also improves the loop gain at low frequencies. This is especially useful for low–side current sensing and sensor interface applications where the signal is low frequency and the differential voltage is relatively small.

#### **APPLICATION CIRCUITS**

#### Low-Side Current Sensing

Low-side current sensing is used to monitor the current through a load. This method can be used to detect over-current conditions and is often used in feedback control, as shown in Figure 18. A sense resistor is placed in series with the load to ground. Typically, the value of the

sense resistor is less than 100 m $\Omega$  to reduce power loss across the resistor. The op amp amplifies the voltage drop across the sense resistor with a gain set by external resistors R1, R2, R3, and R4 (where R1 = R2, R3 = R4). Precision resistors are required for high accuracy, and the gain is set to utilize the full scale of the ADC for the highest resolution.

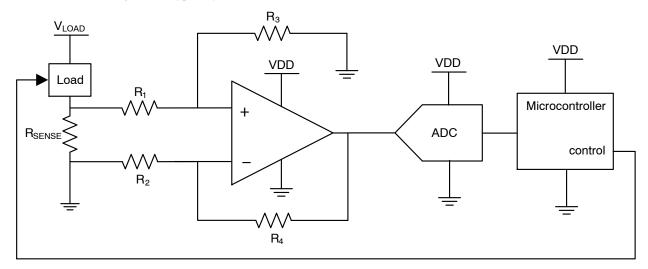


Figure 18. Low-Side Current Sensing

#### **Differential Amplifier for Bridged Circuits**

Sensors to measure strain, pressure, and temperature are often configured in a Wheatstone bridge circuit as shown in Figure 19. In the measurement, the voltage change that is

produced is relatively small and needs to be amplified before going into an ADC. Precision amplifiers are recommended in these types of applications due to their high gain, low noise, and low offset voltage.

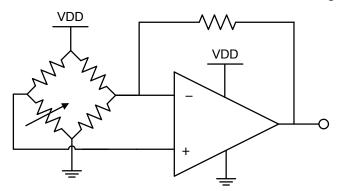


Figure 19. Bridge Circuit Amplification

#### **EMI Susceptibility and Input Filtering**

Op amps have varying amounts of EMI susceptibility. Semiconductor junctions can pick up and rectify EMI signals, creating an EMI-induced voltage offset at the output, adding another component to the total error. Input pins are the most sensitive to EMI. The NCS333 op amp family integrates low-pass filters to decrease sensitivity to EMI.

#### **General Layout Guidelines**

To ensure optimum device performance, it is important to follow good PCB design practices. Place  $0.1~\mu F$  decoupling capacitors as close as possible to the supply pins. Keep traces short, utilize a ground plane, choose surface–mount components, and place components as close as possible to the device pins. These techniques will reduce susceptibility to electromagnetic interference (EMI). Thermoelectric effects can create an additional temperature dependent offset voltage at the input pins. To reduce these effects, use metals with low thermoelectric–coefficients and prevent temperature gradients from heat sources or cooling fans.

#### **UDFN8 Package Guidelines**

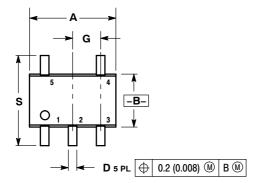
The UDFN8 package has an exposed leadframe die pad on the underside of the package. This pad should be soldered to the PCB, as shown in the recommended soldering footprint in the Package Dimensions section of this datasheet. The center pad can be electrically connected to VSS or it may be left floating. When connected to VSS, the center pad acts as a heat sink, improving the thermal resistance of the part.

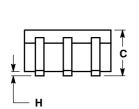


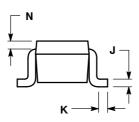
#### SC-88A (SC-70-5/SOT-353) CASE 419A-02 ISSUE L

**DATE 17 JAN 2013** 

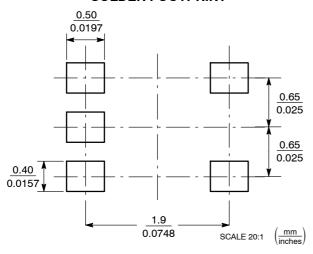
#### SCALE 2:1







#### **SOLDER FOOTPRINT**



- NOTES:
  1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
  2. CONTROLLING DIMENSION: INCH.
- 419A-01 OBSOLETE. NEW STANDARD 419A-02.
- DIMENSIONS A AND B DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE

	INC	HES	MILLIN	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.071	0.087	1.80	2.20
В	0.045	0.053	1.15	1.35
С	0.031	0.043	0.80	1.10
D	0.004	0.012	0.10	0.30
G	0.026	BSC	0.65 BSC	
Н		0.004		0.10
J	0.004	0.010	0.10	0.25
K	0.004	0.012	0.10	0.30
N	0.008 REF		0.20	REF
S	0.079	0.087	2.00	2.20

#### **GENERIC MARKING DIAGRAM\***



XXX = Specific Device Code

= Date Code

= Pb-Free Package

(Note: Microdot may be in either location)

\*This infomration is generic. Please refer to device data sheet for actual part marking.

STYLE 5: PIN 1. CATHODE 2. COMMON ANODE 3. CATHODE 2 4. CATHODE 3

5. CATHODE 4

STYLE 1:	STYLE 2:	STYLE 3:	STYLE 4:
PIN 1. BASE	PIN 1. ANODE	PIN 1. ANODE 1	PIN 1. SOURCE 1
2. EMITTER	2. EMITTER	2. N/C	2. DRAIN 1/2
3. BASE	3. BASE	3. ANODE 2	3. SOURCE 1
4. COLLECTOR	4. COLLECTOR	4. CATHODE 2	4. GATE 1
5. COLLECTOR	5. CATHODE	5. CATHODE 1	5. GATE 2
STYLE 6:	STYLE 7:	STYLE 8: PIN 1. CATHODE 2. COLLECTOR 3. N/C 4. BASE 5. EMITTER	STYLE 9:
PIN 1. EMITTER 2	PIN 1. BASE		PIN 1. ANODE
2. BASE 2	2. EMITTER		2. CATHODE
3. EMITTER 1	3. BASE		3. ANODE
4. COLLECTOR	4. COLLECTOR		4. ANODE
5. COLLECTOR 2/BASE 1	5. COLLECTOR		5. ANODE

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DESCRIPTION:	SC-88A (SC-70-5/SOT-353)		PAGE 1 OF 2



<b>DOCUMENT</b>	NUMBER:
08ASR42084	R

PAGE 2 OF 2

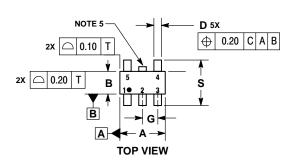
ISSUE	REVISION	DATE
С	CONVERTED FROM PAPER DOCUMENT TO ELECTRONIC. REQ. BY N LAFEB-RE.	20 JUN 1998
D	CONVERTED FROM MOTOROLA TO ON SEMICONDUCTOR. ADDED STYLE 5. REQ. BY E. KIM.	24 JUL 2000
Е	ADDED STYLES 6 & 7. REQ. BY S. BACHMAN.	03 AUG 2000
F	DELETED DIMENSION V, WAS 0.3-0.44MM/0.012-0.016IN. REQ. BY G. KWONG.	14 JUN 2001
G	ADDED STYLE 8, REQ. BY S. CHANG; ADDED STYLE 9, REQ. BY S. BACHMAN; ADDED NOTE 4, REQ. BY S. RIGGS	25 JUN 2003
Н	CHANGED STYLE 6. REQ. BY C. LIM	28 APR 2005
J	CHANGED TITLE DESCRIPTION. REQ. BY B. LOFTS.	31 AUG 2005
K	CORRECTED TITLE AND DESCRIPTION TO SC-88A (SC-70-5/SOT-353). CORRECTED MARKING DIAGRAM. REQ. BY D. TRUHITTE.	13 JUL 2010
L	ADDED SOLDER FOOTPRINT. REQ. BY I. MARIANO.	17 JAN 2013
	<u> </u>	

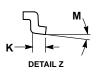
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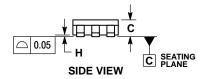


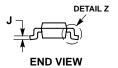
TSOP-5 **CASE 483** ISSUE M

**DATE 17 MAY 2016** 





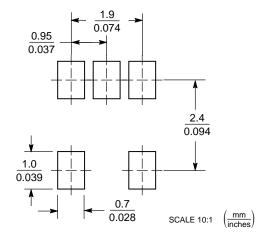




- NOTES:
  1. DIMENSIONING AND TOLERANCING PER ASME
- DIMENSIONING AND TOLERANCING FER ASME Y14.5M, 1994. CONTROLLING DIMENSION: MILLIMETERS. MAXIMUM LEAD THICKNESS INCLUDES LEAD FINISH THICKNESS. MINIMUM LEAD THICKNESS IS THE MINIMUM THICKNESS OF BASE MATERIAL.
- DIMENSIONS A AND B DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.15 PER SIDE. DIMENSION A.
- OPTIONAL CONSTRUCTION: AN ADDITIONAL TRIMMED LEAD IS ALLOWED IN THIS LOCATION. TRIMMED LEAD NOT TO EXTEND MORE THAN 0.2 FROM BODY.

	MILLIMETERS				
DIM	MIN	MAX			
Α	2.85	3.15			
В	1.35	1.65			
C	0.90	1.10			
D	0.25	0.50			
G	0.95	0.95 BSC			
Н	0.01	0.10			
J	0.10	0.26			
K	0.20	0.60			
M	0 °	10°			
S	2.50	3.00			

#### **SOLDERING FOOTPRINT\***



\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

#### **GENERIC MARKING DIAGRAM\***





Discrete/Logic

XXX = Specific Device Code

XX = Specific Device Code = Date Code = Assembly Location

= Year

= Pb-Free Package

= Work Week = Pb-Free Package

(Note: Microdot may be in either location)

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " ■", may or may not be present.

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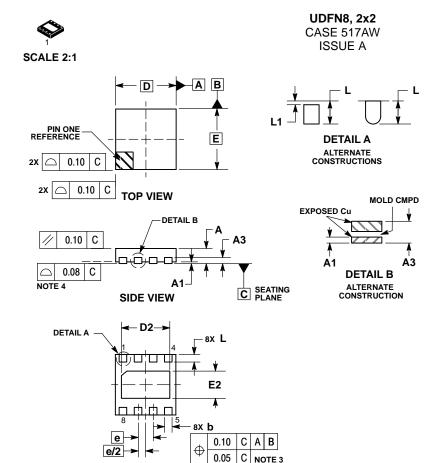


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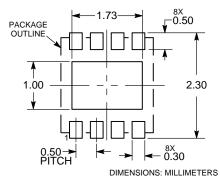
INITIATED NEW MECHANICAL OUTLINE #483. REQ BY WL CHIN/L. RENNICK.	28 OCT 1998
UPDATE OUTLINE DRAWING TO CORRECT DIN "C" (SHOULD BE FROM TIP OF LID TO TOP OF PKG). DIM IN TABLE INCORRECTLY LISTED TO G, F TO H, H TO J, N TO L & R TO M. REQ BY F. PADILLA	13 NOV 1998
CHANGE OF LEGAL ONWERSHIP FROM MOTOROLA TO ON SEMICONDUCTOR. REQ BY A. GARLINGTON	20 APR 2001
ADDED NOTE "4". REQ BY S. RIGGS	27 JUN 2003
ADDED FOOTPRINT INFORMATION. UPDATED MARKING. REQ. BY D. JOERSZ	07 APR 2005
CHANGED DEVICE MARKING FROM AWW TO AYW. REQ. BY J. MANES.	14 SEP 2005
UPDATED DRAWINGS TO LATEST JEDEC STANDARDS. ADDED NOTE 5. REQ. BY T. GURNETT.	07 JUN 2006
ADDED MARKING DIAGRAM FOR IC OPTION. REQ. BY J. MILLER.	21 FEB 2007
CORRECTED MARKING DIAGRAM ERROR BY REVERSING ANALOG AND DISCRETE LABELS. REQ. BY GK SUA.	18 MAY 2007
CHANGED NOTE 4. REQ. BY A. GARLINGTON.	13 MAR 2013
REMOVED DIMENSION L AND ADDED DATUMS A AND B TO TOP VIEW. REQ. BY A. GARLINGTON.	19 APR 2013
REMOVED -02 FROM CASE CODE VARIANT. REQ. BY N. CALZADA.	23 SEP 2015
CHANGED DIMENSIONS A & B FROM BASIC TO MIN AND MAX VALUES. REQ. BY A. GARLINGTON.	17 MAY 2016
	LID TO TOP OF PKG). DIM IN TABLE INCORRECTLY LISTED TO G, F TO H, H TO J, N TO L & R TO M. REQ BY F. PADILLA  CHANGE OF LEGAL ONWERSHIP FROM MOTOROLA TO ON SEMICONDUCTOR. REQ BY A. GARLINGTON  ADDED NOTE "4". REQ BY S. RIGGS  ADDED FOOTPRINT INFORMATION. UPDATED MARKING. REQ. BY D. JOERSZ  CHANGED DEVICE MARKING FROM AWW TO AYW. REQ. BY J. MANES.  UPDATED DRAWINGS TO LATEST JEDEC STANDARDS. ADDED NOTE 5. REQ. BY T. GURNETT.  ADDED MARKING DIAGRAM FOR IC OPTION. REQ. BY J. MILLER.  CORRECTED MARKING DIAGRAM ERROR BY REVERSING ANALOG AND DISCRETE LABELS. REQ. BY GK SUA.  CHANGED NOTE 4. REQ. BY A. GARLINGTON.  REMOVED DIMENSION L AND ADDED DATUMS A AND B TO TOP VIEW. REQ. BY A. GARLINGTON.  REMOVED -02 FROM CASE CODE VARIANT. REQ. BY N. CALZADA.  CHANGED DIMENSIONS A & B FROM BASIC TO MIN AND MAX VALUES. REQ.

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#### **RECOMMENDED SOLDERING FOOTPRINT\***

**BOTTOM VIEW** 



\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

**DATE 13 NOV 2015** 

#### NOTES:

- DIMENSIONING AND TOLERANCING PER
   ASME Y14.5M, 1994.
- ASMET 14-3M, 1994.
  CONTROLLING DIMENSION: MILLIMETERS.
  DIMENSION 6 APPLIES TO PLATED TERMINALS AND IS MEASURED BETWEEN 0.15
  AND 0.30 MM FROM THE TERMINAL TIP.

- AND 0.30 MM FROM THE TERMINAL TIP.
  COPLANARITY APPLIES TO THE EXPOSED
  PAD AS WELL AS THE TERMINALS.
  FOR DEVICE OPN CONTAINING W OPTION,
  DETAIL B ALTERNATE CONSTRUCTION IS
  NOT APPLICABLE.

	MILLIMETERS	
DIM	MIN	MAX
Α	0.45	0.55
A1	0.00	0.05
A3	0.13	REF
b	0.18	0.30
D	2.00	BSC
D2	1.50	1.70
E	2.00	BSC
E2	0.80	1.00
е	0.50 BSC	
L	0.20	0.45
L1		0.15

#### **GENERIC MARKING DIAGRAM\***



XX = Specific Device Code

= Date Code

= Pb-Free Package

(Note: Microdot may be in either location)

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " ■", may or may not be present.

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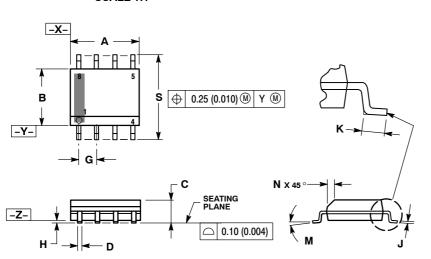
PAGE 2 OF 2

ISSUE	REVISION	DATE
0	RELEASED FOR PRODUCTION FROM POD #UDFN8-033-01 TO ON SEMICONDUCTOR. REQ. BY B. BERGMAN.	19 DEC 2008
Α	REDREW TO JEDEC STANDARDS. REQ. BY I. HYLAND.	13 NOV 2015

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**DATE 16 FEB 2011** 



XS

- NOTES:

  1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.

  2. CONTROLLING DIMENSION: MILLIMETER.

  3. DIMENSION A AND B DO NOT INCLUDE MOLD PROTRUSION.

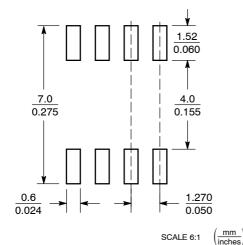
  4. MAXIMUM MOLD PROTRUSION 0.15 (0.006)
- PER SIDE.

  5. DIMENSION D DOES NOT INCLUDE DAMBAR
- PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.127 (0.005) TOTAL IN EXCESS OF THE D DIMENSION AT MAXIMUM MATERIAL CONDITION. 751–01 THRU 751–06 ARE OBSOLETE. NEW STANDARD IS 751–07.

	MILLIMETERS		ETERS INCHES	
DIM	MIN	MAX	MIN	MAX
Α	4.80	5.00	0.189	0.197
В	3.80	4.00	0.150	0.157
С	1.35	1.75	0.053	0.069
D	0.33	0.51	0.013	0.020
G	1.27 BSC		0.050 BSC	
Н	0.10	0.25	0.004	0.010
J	0.19	0.25	0.007	0.010
K	0.40	1.27	0.016	0.050
М	0 °	8 °	0 °	8 °
N	0.25	0.50	0.010	0.020
S	5.80	6.20	0.228	0.244

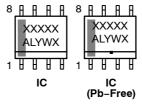
#### **SOLDERING FOOTPRINT\***

0.25 (0.010) M Z Y S



\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

#### **GENERIC MARKING DIAGRAM\***



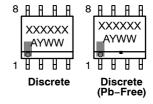
XXXXX = Specific Device Code

= Assembly Location Α = Wafer Lot

= Year

= Work Week W

= Pb-Free Package



XXXXXX = Specific Device Code = Assembly Location Α

WW = Work Week

= Pb-Free Package

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G", may or not be present.

#### **STYLES ON PAGE 2**

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#### SOIC-8 NB CASE 751-07 ISSUE AK

#### **DATE 16 FEB 2011**

STYLE 1: PIN 1. EMITTER 2. COLLECTOR 3. COLLECTOR 4. EMITTER 5. EMITTER 6. BASE 7. BASE 8. EMITTER	STYLE 2: PIN 1. COLLECTOR, DIE, #1 2. COLLECTOR, #1 3. COLLECTOR, #2 4. COLLECTOR, #2 5. BASE, #2 6. EMITTER, #2 7. BASE, #1 8. EMITTER, #1	STYLE 3: PIN 1. DRAIN, DIE #1 2. DRAIN, #1 3. DRAIN, #2 4. DRAIN, #2 5. GATE, #2 6. SOURCE, #2 7. GATE, #1 8. SOURCE, #1	STYLE 4: PIN 1. ANODE 2. ANODE 3. ANODE 4. ANODE 5. ANODE 6. ANODE 7. ANODE 8. COMMON CATHODE
STYLE 5: PIN 1. DRAIN 2. DRAIN 3. DRAIN 4. DRAIN 5. GATE 6. GATE 7. SOURCE 8. SOURCE	STYLE 6: PIN 1. SOURCE 2. DRAIN 3. DRAIN 4. SOURCE 5. SOURCE 6. GATE 7. GATE 8. SOURCE	STYLE 7: PIN 1. INPUT 2. EXTERNAL BYPASS 3. THIRD STAGE SOURCE 4. GROUND 5. DRAIN 6. GATE 3 7. SECOND STAGE Vd 8. FIRST STAGE Vd	STYLE 8:  PIN 1. COLLECTOR, DIE #1  2. BASE, #1  3. BASE, #2  4. COLLECTOR, #2  5. COLLECTOR, #2  6. EMITTER, #2  7. EMITTER, #1  8. COLLECTOR, #1
STYLE 9: PIN 1. EMITTER, COMMON 2. COLLECTOR, DIE #1 3. COLLECTOR, DIE #2 4. EMITTER, COMMON 5. EMITTER, COMMON 6. BASE, DIE #2 7. BASE, DIE #1 8. EMITTER, COMMON	STYLE 10: PIN 1. GROUND 2. BIAS 1 3. OUTPUT 4. GROUND 5. GROUND 6. BIAS 2 7. INPUT 8. GROUND	STYLE 11: PIN 1. SOURCE 1 2. GATE 1 3. SOURCE 2 4. GATE 2 5. DRAIN 2 6. DRAIN 2 7. DRAIN 1 8. DRAIN 1	STYLE 12: PIN 1. SOURCE 2. SOURCE 3. SOURCE 4. GATE 5. DRAIN 6. DRAIN 7. DRAIN 8. DRAIN
STYLE 13: PIN 1. N.C. 2. SOURCE 3. SOURCE 4. GATE 5. DRAIN 6. DRAIN 7. DRAIN 8. DRAIN	STYLE 14: PIN 1. N-SOURCE 2. N-GATE 3. P-SOURCE 4. P-GATE 5. P-DRAIN 6. P-DRAIN 7. N-DRAIN 8. N-DRAIN	STYLE 15: PIN 1. ANODE 1 2. ANODE 1 3. ANODE 1 4. ANODE 1 5. CATHODE, COMMON 6. CATHODE, COMMON 7. CATHODE, COMMON 8. CATHODE, COMMON	STYLE 16: PIN 1. EMITTER, DIE #1 2. BASE, DIE #1 3. EMITTER, DIE #2 4. BASE, DIE #2 5. COLLECTOR, DIE #2 6. COLLECTOR, DIE #2 7. COLLECTOR, DIE #1 8. COLLECTOR, DIE #1
STYLE 17: PIN 1. VCC 2. V2OUT 3. V1OUT 4. TXE 5. RXE 6. VEE 7. GND 8. ACC	STYLE 18: PIN 1. ANODE 2. ANODE 3. SOURCE 4. GATE 5. DRAIN 6. DRAIN 7. CATHODE 8. CATHODE	STYLE 19: PIN 1. SOURCE 1 2. GATE 1 3. SOURCE 2 4. GATE 2 5. DRAIN 2 6. MIRROR 2 7. DRAIN 1 8. MIRROR 1	STYLE 20: PIN 1. SOURCE (N) 2. GATE (N) 3. SOURCE (P) 4. GATE (P) 5. DRAIN 6. DRAIN 7. DRAIN 8. DRAIN
STYLE 21: PIN 1. CATHODE 1 2. CATHODE 2 3. CATHODE 3 4. CATHODE 4 5. CATHODE 5 6. COMMON ANODE 7. COMMON ANODE 8. CATHODE 6	STYLE 22: PIN 1. I/O LINE 1 2. COMMON CATHODE/VCC 3. COMMON CATHODE/VCC 4. I/O LINE 3 5. COMMON ANODE/GND 6. I/O LINE 4 7. I/O LINE 5 8. COMMON ANODE/GND	4. LINE 2 IN	STYLE 24: PIN 1. BASE 2. EMITTER 3. COLLECTOR/ANODE 4. COLLECTOR/ANODE 5. CATHODE 6. CATHODE 7. COLLECTOR/ANODE 8. COLLECTOR/ANODE
STYLE 25: PIN 1. VIN 2. N/C 3. REXT 4. GND 5. IOUT 6. IOUT 7. IOUT 8. IOUT	STYLE 26: PIN 1. GND 2. dv/dt 3. ENABLE 4. ILIMIT 5. SOURCE 6. SOURCE 7. SOURCE 8. VCC	STYLE 27: PIN 1. ILIMIT 2. OVLO 3. UVLO 4. INPUT+ 5. SOURCE 6. SOURCE 7. SOURCE 8. DRAIN	STYLE 28: PIN 1. SW_TO_GND 2. DASIC_OFF 3. DASIC_SW_DET 4. GND 5. V_MON 6. VBULK 7. VBULK 8. VIN
STYLE 29: PIN 1. BASE, DIE #1 2. EMITTER, #1 3. BASE, #2 4. EMITTER, #2 5. COLLECTOR, #2 6. COLLECTOR, #2 7. COLLECTOR, #1 8. COLLECTOR, #1	STYLE 30: PIN 1. DRAIN 1 2. DRAIN 1 3. GATE 2 4. SOURCE 2 5. SOURCE 1/DRAIN 2 6. SOURCE 1/DRAIN 2 7. SOURCE 1/DRAIN 2 8. GATE 1		

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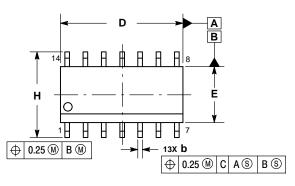
ISSUE	REVISION	DATE
AB	ADDED STYLE 25. REQ. BY S. CHANG.	15 MAR 2004
AC	ADDED CORRECTED MARKING DIAGRAMS. REQ. BY S. FARRETTA.	13 AUG 2004
AD	CORRECTED MARKING DIAGRAM FOR DISCRETE. REQ. BY S. FARRETTA.	18 NOV 2004
AE	UPDATED SCALE ON FOOTPRINT. REQ. BY S. WEST.	31 JAN 2005
AF	UPDATED MARKING DIAGRAMS. REQ. BY S. WEST. ADDED STYLE 26. REQ. BY S. CHANG.	14 APR 2005
AG	ADDED STYLE 27. REQ. BY S. CHANG.	30 JUN 2005
AH	ADDED STYLE 28. REQ. BY S. CHANG.	09 MAR 2006
AJ	ADDED STYLE 29. REQ. BY D. HELZER.	19 SEP 2007
AK	ADDED STYLE 30. REQ. BY I. CAMBALIZA.	16 FEB 2011

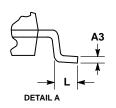
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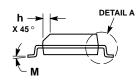


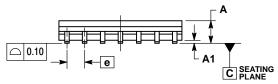
SOIC-14 NB CASE 751A-03 ISSUE L

**DATE 03 FEB 2016** 









# GENERIC MARKING DIAGRAM\*

INCHES

MIN MAX

0.050 BSC

NOTES:
1. DIMENSIONING AND TOLERANCING PER

ASME Y14.5M, 1994.
2. CONTROLLING DIMENSION: MILLIMETERS.
3. DIMENSION b DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE PROTRUSION SHALL BE 0.13 TOTAL IN EXCESS OF AT

MAXIMUM MATERIAL CONDITION.
4. DIMENSIONS D AND E DO NOT INCLUDE MOLD PROTRUSIONS.

5. MAXIMUM MOLD PROTRUSION 0.15 PER

 A
 1.35
 1.75
 0.054
 0.068

 A1
 0.10
 0.25
 0.004
 0.010

 A3
 0.19
 0.25
 0.008
 0.010

0.35 0.49 0.014 0.019

8.55 8.75 0.337 0.344 3.80 4.00 0.150 0.157

 5.80
 6.20
 0.228
 0.244

 0.25
 0.50
 0.010
 0.019

0.40 1.25 0.016 0.049

MILLIMETERS

1.27 BSC

DIM MIN MAX

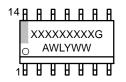
SIDE

b

D E

e H

h



XXXXX = Specific Device Code A = Assembly Location

WL = Wafer Lot
 Y = Year
 WW = Work Week
 G = Pb-Free Package

\*This information is generic. Please refer to device data sheet for actual part marking. Pb–Free indicator, "G" or microdot " •", may or may not be present.

# 

\*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

**DIMENSIONS: MILLIMETERS** 

#### **STYLES ON PAGE 2**

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#### SOIC-14 CASE 751A-03 ISSUE L

#### DATE 03 FEB 2016

STYLE 1: PIN 1. COMMON CATHODE 2. ANODE/CATHODE 3. ANODE/CATHODE 4. NO CONNECTION 5. ANODE/CATHODE 6. NO CONNECTION 7. ANODE/CATHODE 8. ANODE/CATHODE 9. ANODE/CATHODE 10. NO CONNECTION 11. ANODE/CATHODE 12. ANODE/CATHODE 13. NO CONNECTION 14. COMMON ANODE	STYLE 2: CANCELLED	STYLE 3: PIN 1. NO CONNECTION 2. ANODE 3. ANODE 4. NO CONNECTION 5. ANODE 6. NO CONNECTION 7. ANODE 8. ANODE 9. ANODE 10. NO CONNECTION 11. ANODE 12. ANODE 13. NO CONNECTION 14. COMMON CATHODE	STYLE 4: PIN 1. NO CONNECTION 2. CATHODE 3. CATHODE 4. NO CONNECTION 5. CATHODE 6. NO CONNECTION 7. CATHODE 8. CATHODE 9. CATHODE 10. NO CONNECTION 11. CATHODE 12. CATHODE 13. NO CONNECTION 14. COMMON ANODE
STYLE 5: PIN 1. COMMON CATHODE 2. ANODE/CATHODE 3. ANODE/CATHODE 4. ANODE/CATHODE 5. ANODE/CATHODE 6. NO CONNECTION 7. COMMON ANODE 8. COMMON CATHODE 9. ANODE/CATHODE 10. ANODE/CATHODE 11. ANODE/CATHODE 12. ANODE/CATHODE 13. NO CONNECTION 14. COMMON ANODE	STYLE 6: PIN 1. CATHODE 2. CATHODE 3. CATHODE 4. CATHODE 5. CATHODE 6. CATHODE 7. CATHODE 8. ANODE 9. ANODE 10. ANODE 11. ANODE 12. ANODE 13. ANODE 14. ANODE	STYLE 7: PIN 1. ANODE/CATHODE 2. COMMON ANODE 3. COMMON CATHODE 4. ANODE/CATHODE 5. ANODE/CATHODE 6. ANODE/CATHODE 7. ANODE/CATHODE 8. ANODE/CATHODE 9. ANODE/CATHODE 10. ANODE/CATHODE 11. COMMON CATHODE 12. COMMON CATHODE 13. ANODE/CATHODE 14. ANODE/CATHODE 14. ANODE/CATHODE	STYLE 8: PIN 1. COMMON CATHODE 2. ANODE/CATHODE 3. ANODE/CATHODE 4. NO CONNECTION 5. ANODE/CATHODE 6. ANODE/CATHODE 7. COMMON ANODE 8. COMMON ANODE 9. ANODE/CATHODE 10. ANODE/CATHODE 11. NO CONNECTION 12. ANODE/CATHODE 13. ANODE/CATHODE 14. COMMON CATHODE

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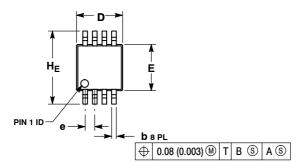
ISSUE	REVISION	DATE
G	ADDED MARKING DIAGRAM. REQ. BY S. FARRETTA	30 APR 2004
Н	ADDED SOLDERING FOOTPRINT. REQ. BY S. RIGGS.	04 OCT 2006
J	CORRECTED MARKING DIAGRAM. MOVED PB-FREE INDICATOR "G" TO TOP LINE. REQ. BY C. BIAS.	13 FEB 2008
K	UPDATED DRAWING TO JEDEC STANDARDS. REQ. BY I. CAMBALIZA.	31 MAY 2011
L	ADDED COPLANARITY TOLERANCE BOX TO SIDE VIEW. REQ. BY F. ESTRADA.	03 FEB 2016

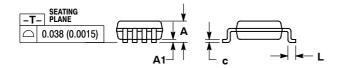
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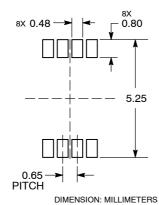
Micro8™ CASE 846A-02 **ISSUE J** 

**DATE 02 JUL 2013** 





#### **RECOMMENDED SOLDERING FOOTPRINT\***



\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

#### NOTES

- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
- CONTROLLING DIMENSION: MILLIMETER.
   DIMENSION A DOES NOT INCLUDE MOLD FLASH, PROTRUSIONS OR GATE BURRS. MOLD FLASH, PROTRUSIONS OR GATE BURRS SHALL NOT EXCEED 0.15 (0.006) PER SIDE
- DIMENSION B DOES NOT INCLUDE INTERLEAD FLASH OR PROTRUSION.
  INTERLEAD FLASH OR PROTRUSION SHALL NOT EXCEED 0.25 (0.010) PER SIDE.
- 846A-01 OBSOLETE, NEW STANDARD 846A-02.

	MILLIMETERS			INCHES		
DIM	MIN	NOM	MAX	MIN	NOM	MAX
Α			1.10		-	0.043
A1	0.05	0.08	0.15	0.002	0.003	0.006
b	0.25	0.33	0.40	0.010	0.013	0.016
С	0.13	0.18	0.23	0.005	0.007	0.009
D	2.90	3.00	3.10	0.114	0.118	0.122
E	2.90	3.00	3.10	0.114	0.118	0.122
е		0.65 BSC 0.026 BSC		)		
L	0.40	0.55	0.70	0.016	0.021	0.028
HE	4.75	4.90	5.05	0.187	0.193	0.199

#### **GENERIC MARKING DIAGRAM\***



XXXX = Specific Device Code Α = Assembly Location

= Year = Work Week W = Pb-Free Package

(Note: Microdot may be in either location)

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " •", may or may not be present.

STYLE 1:	STYLE 2:	9	STYLE 3:
PIN 1. S	OURCE PIN 1.	SOURCE 1	PIN 1. N-SOURCE
2. S	OURCE 2.	GATE 1	<ol><li>N-GATE</li></ol>
3. S	OURCE 3.	SOURCE 2	<ol><li>P-SOURCE</li></ol>
4. G	GATE 4.	GATE 2	<ol><li>P-GATE</li></ol>
5. D	DRAIN 5.	DRAIN 2	<ol><li>P-DRAIN</li></ol>
6. D	DRAIN 6.	DRAIN 2	<ol><li>P-DRAIN</li></ol>
7. D	DRAIN 7.	DRAIN 1	7. N-DRAIN
8. D	DRAIN 8.	DRAIN 1	8. N-DRAIN

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ISSUE	REVISION	DATE
G	ADDED NOMINAL VALUES AND UPDATED GENERIC MARKING DIAGRAM. REQ. BY HONG XIAO	18 JUL 2005
Н	CORRECTED GENERIC MARKING INFORMATION. REQ. BY T. GURNETT.	12 NOV 2007
J	CORRECTED SOLDERING FOOTPRINT. REQ. BY J. LIU.	02 JUL 2013

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